



# COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET POWERDI

### **Product Summary**

Device	BV <sub>DSS</sub>	R <sub>DS(ON)</sub> max	I <sub>D</sub> max T <sub>C</sub> = +25°C	
Q1	30V 25mΩ @ V <sub>GS</sub> = 10V		15A	
Q1	30 V	$35m\Omega @ V_{GS} = 4.5V$	12.5A	
Q2	-30V	25mΩ @ V <sub>GS</sub> = -10V		-15A
Q2		$38m\Omega$ @ V <sub>GS</sub> = -4.5V	-12A	

#### Description

This new generation MOSFET is designed to minimize the on-state resistance (R<sub>DS(ON)</sub>) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

### **Applications**

- Power Management Functions
- Analog Switch

#### **Features**

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Complementary Pair MOSFET
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

#### **Mechanical Data**

- Case: PowerDI3333-8 (Type UXC)
- Case Material: Molded Plastic, "Green" Molding Compound.
   UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections Indicator: See Diagram
- Terminals: Finish Matte Tin Annealed over Copper Leadframe.
   Solderable per MIL-STD-202, Method 208 <sup>3</sup>

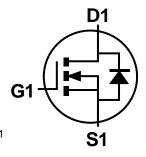
**Equivalent Circuit** 

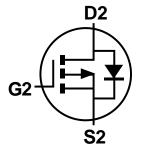
• Weight: 0.072 grams (Approximate)

PowerDI3333-8 (Type UXC)



D2 D1 D1 G2 S2 G1 PIN1





Top View

**Bottom View** 

N-Channel MOSFET

P-Channel MOSFET

### Ordering Information (Note 4)

Part Number	Case	Packaging
DMC3025LDV-7	PowerDI3333-8 (Type UXC)	2000/Tape & Reel
DMC3025LDV-13	PowerDI3333-8 (Type UXC)	3000/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead\_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

### **Marking Information**



SD9 = Product Type Marking Code

YYWW = Date Code Marking

YY = Last Two Digits of Year (ex: 16 for 2016)

WW = Week Code (01 to 53)



### Maximum Ratings Q1 N-CHANNEL (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units		
Drain-Source Voltage			$V_{DSS}$	30	V
Gate-Source Voltage	$V_{GSS}$	±20	V		
Continuous Drain Current, $V_{GS} = 10V$ (Note 7)  Steady $T_C = +25^{\circ}C$ State $T_C = +70^{\circ}C$			I <sub>D</sub>	15 12	А
Maximum Body Diode Forward Current (Note 6)	I <sub>S</sub>	2	Α		
Pulsed Drain Current (380µs Pulse, Duty Cycle = 1%)			I <sub>DM</sub>	55	Α
Avalanche Current (L = 0.1mH) (Note 8)			I <sub>AS</sub>	14	Α
Avalanche Energy (L = 0.1mH) (Note 8)			E <sub>AS</sub>	9.8	mJ

## Maximum Ratings Q2 P-CHANNEL (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units		
Drain-Source Voltage			$V_{DSS}$	-30	V
Gate-Source Voltage	$V_{GSS}$	±20	V		
Continuous Drain Current, V <sub>GS</sub> = -10V (Note 7)	I <sub>D</sub>	-15 -12	А		
Maximum Body Diode Forward Current (Note 6)	I <sub>S</sub>	-2	Α		
Pulsed Drain Current (380µs Pulse, Duty Cycle = 1%)	I <sub>DM</sub>	-45	Α		
Avalanche Current (L = 0.1mH) (Note 8)			I <sub>AS</sub>	-22	Α
Avalanche Energy (L = 0.1mH) (Note 8)			E <sub>AS</sub>	24	mJ

#### Thermal Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic		Symbol	Value	Unit	
Total Power Dissipation (Note 5)		$P_{D}$	1.0	W	
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	-	119	°C/W	
Thermal Resistance, Junction to Ambient (Note 5)	t<10s	$R_{\theta JA}$	72	C/VV	
Total Power Dissipation (Note 6)		P <sub>D</sub>	1.9	W	
Thermal Resistance, Junction to Ambient (Note 6)  Steady t<10		$R_{\theta JA}$	66	°C/W	
			38		
Thermal Resistance, Junction to Case (Note 7)		$R_{\theta JC}$	15		
Operating and Storage Temperature Range		T <sub>J,</sub> T <sub>STG</sub>	-55 to +150	°C	



### Electrical Characteristics N-CHANNEL - Q1 (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 9)						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	30	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current T <sub>J</sub> = +25°C	I <sub>DSS</sub>	I	-	1	μΑ	$V_{DS} = 30V, V_{GS} = 0V$
Gate-Source Leakage	$I_{GSS}$	1	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 9)						
Gate Threshold Voltage	V <sub>GS(TH)</sub>	1.0	_	2.0	V	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$
Static Drain-Source On-Resistance			15	25	mΩ	$V_{GS} = 10V, I_D = 7A$
Static Dialii-Source Off-Resistance	R <sub>DS(ON)</sub>	I	24	35	11122	$V_{GS} = 4.5V, I_D = 7A$
Diode Forward Voltage	$V_{SD}$	I	0.70	1.0	٧	$V_{GS} = 0V, I_{S} = 1A$
DYNAMIC CHARACTERISTICS (Note 10)						
Input Capacitance	C <sub>iss</sub>	-	500	_		\\ 45\\\\\ 0\\
Output Capacitance	Coss	-	72	-	pF	$V_{DS} = 15V, V_{GS} = 0V,$ f = 1.0MHz
Reverse Transfer Capacitance	$C_{rss}$		57	_		
Gate Resistance	$R_{G}$	_	1.9	_	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$
Total Gate Charge (V <sub>GS</sub> = 4.5V)	Qg	ļ	4.6	_		
Total Gate Charge (V <sub>GS</sub> = 10V)	Qg	_	9.8	_	nC	V <sub>DS</sub> = 15V. I <sub>D</sub> = 10A
Gate-Source Charge	$Q_{gs}$	-	1.6	-	IIC	V <sub>DS</sub> = 15V, I <sub>D</sub> = 10A
Gate-Drain Charge	$Q_{gd}$	-	2.0	-		
Turn-On Delay Time	t <sub>D(ON)</sub>	_	3.9	_		
Turn-On Rise Time	t <sub>R</sub>	_	4.2	-	ns	$V_{DD} = 15V, V_{GS} = 10V,$
Turn-Off Delay Time	t <sub>D(OFF)</sub>	I	16.6	_	ns	$R_G = 6\Omega$ , $I_D = 1A$
Turn-Off Fall Time	$t_F$	I	5.8	_		
Reverse Recovery Time	t <sub>RR</sub>		5.6	=	ns	I 124 di/dt - 5004/us
Reverse Recovery Charge	$Q_{RR}$	-	2.6	-	nC	I <sub>F</sub> = 12A, di/dt = 500A/μs

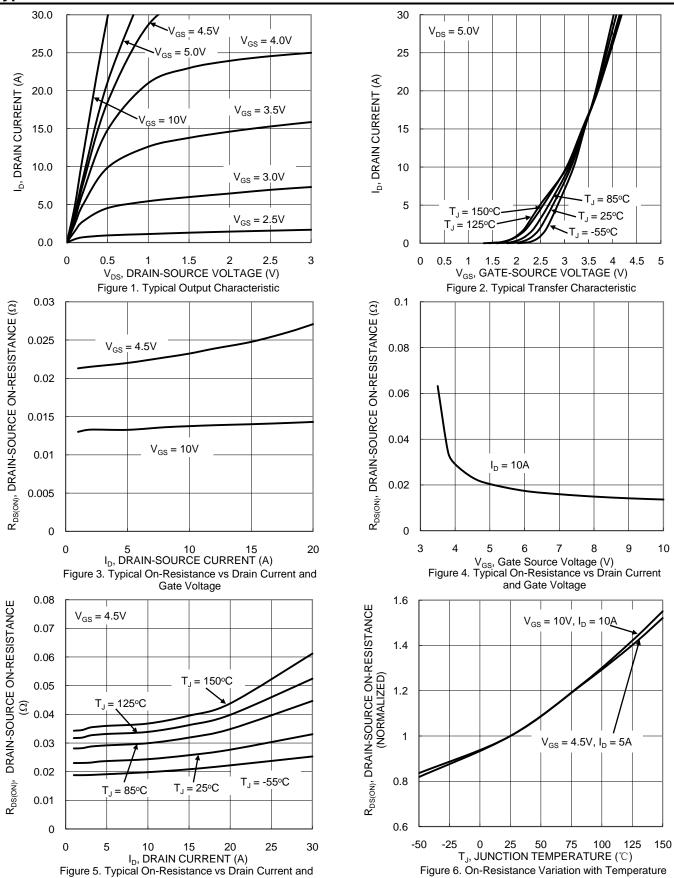
### Electrical Characteristics P-CHANNEL - Q2 (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 9)						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-30	-	_	V	$V_{GS} = 0V, I_D = -250\mu A$
Zero Gate Voltage Drain Current T <sub>J</sub> = +25°C	I <sub>DSS</sub>	_	-	-1	μA	$V_{DS} = -30V, V_{GS} = 0V$
Gate-Source Leakage	I <sub>GSS</sub>	_	-	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 9)						
Gate Threshold Voltage	V <sub>GS(TH)</sub>	-1.2	-	-2.4	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$
Static Drain-Source On-Resistance			21	25	mΩ	$V_{GS} = -10V, I_D = -7A$
Static Dialii-Source Off-Resistance	R <sub>DS(ON)</sub>	1	31	38	11122	$V_{GS} = -4.5V$ , $I_D = -6.2A$
Diode Forward Voltage	$V_{SD}$	_	-0.7	-1.2	V	$V_{GS} = 0V, I_{S} = -2.1A$
DYNAMIC CHARACTERISTICS (Note 10)						•
Input Capacitance	C <sub>iss</sub>	-	1,188	_		45)/ )/ 0)/
Output Capacitance	Coss	-	154	_	pF	$V_{DS} = -15V$ , $V_{GS} = 0V$ , $f = 1MHz$
Reverse Transfer Capacitance	C <sub>rss</sub>	_	116	_		
Gate Resistance	Rg	_	9	_	Ω	$V_{DS} = 0V$ , $V_{GS} = 0V$ , $f = 1MHz$
Total Gate Charge (V <sub>GS</sub> = -4.5V)	$Q_{g}$	_	9.5	_		
Total Gate Charge (V <sub>GS</sub> = -10V)	$Q_{g}$	_	19.7	_	nC	\/ 45\/ 1 70
Gate-Source Charge	$Q_{gs}$	_	3.1	_	IIC	$V_{DS} = -15V, I_{D} = -7A$
Gate-Drain Charge	Q <sub>qd</sub>	-	3.2	_		
Turn-On Delay Time	t <sub>D(ON)</sub>	_	3.7	_		
Turn-On Rise Time	t <sub>R</sub>	-	2.6	_		$V_{GS} = -10V, V_{DS} = -15V,$
Turn-Off Delay Time	t <sub>D(OFF)</sub>	_	36	_	ns	$R_G = 6\Omega$ , $I_D = -7A$
Turn-Off Fall Time	t <sub>F</sub>	_	22	_		
Reverse Recovery Time	t <sub>RR</sub>	-	10.4	_	ns	1 70 4:/4+ 4000/
Reverse Recovery Charge	Q <sub>RR</sub>	_	3.2	_	nC	$I_F = -7A$ , di/dt = 100A/ $\mu$ s

- 5. Device mounted on FR-4 PC board, with minimum recommended pad layout, single sided.
- 6. Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate.
- 7. Thermal resistance from junction to soldering point (on the exposed drain pad). 8.  $I_{AS}$  and  $E_{AS}$  rating are based on low frequency and duty cycles to keep  $T_J = +25^{\circ}C$ .
- 9. Short duration pulse test used to minimize self-heating effect.
- 10. Guaranteed by design. Not subject to product testing.



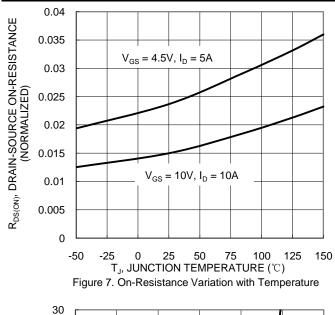
### **Typical Characteristics - N-CHANNEL**

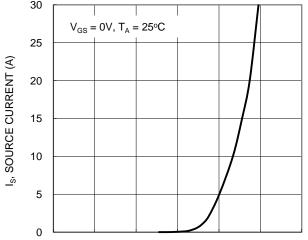


Temperature



#### **Typical Characteristics - N-CHANNEL (Cont.)**

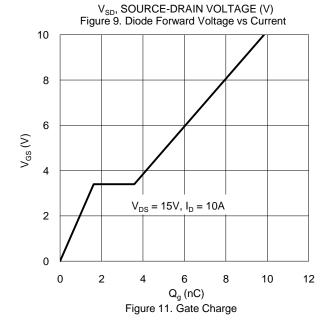


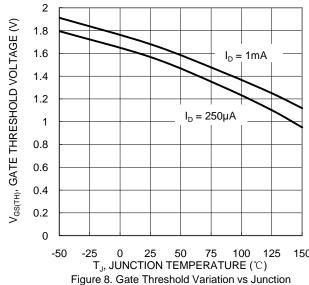


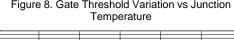
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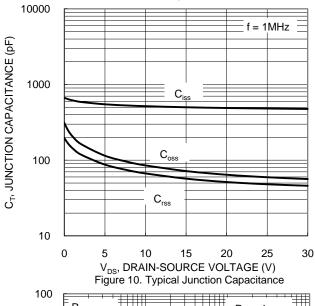
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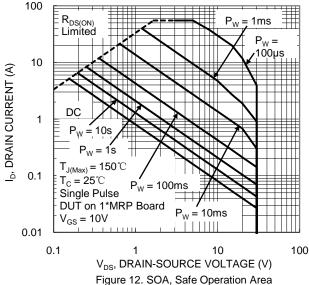
1.2







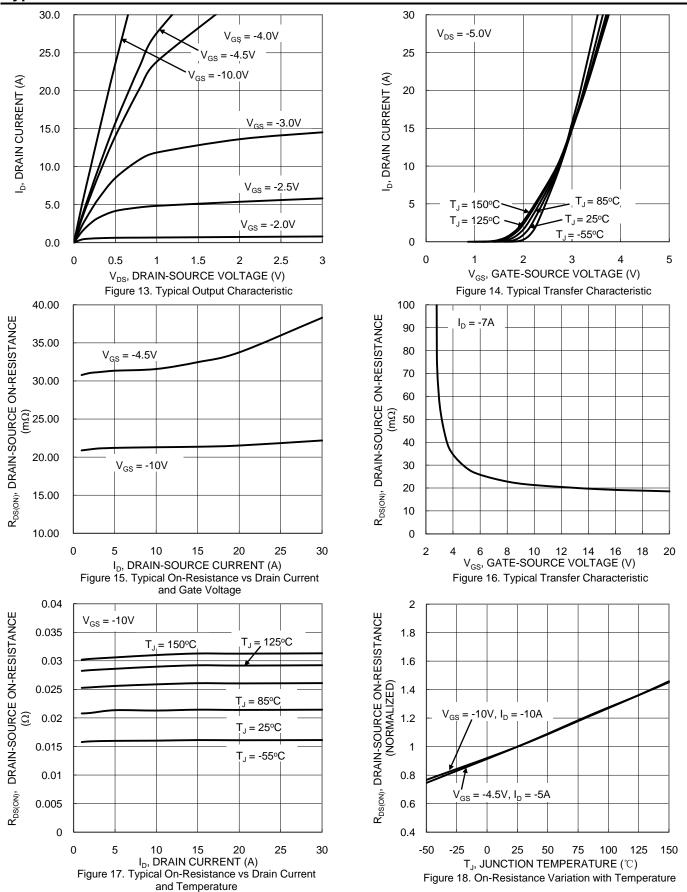




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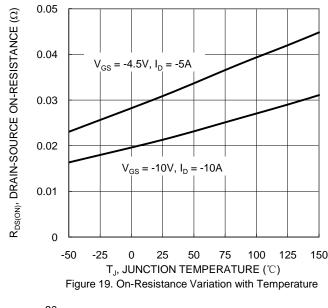


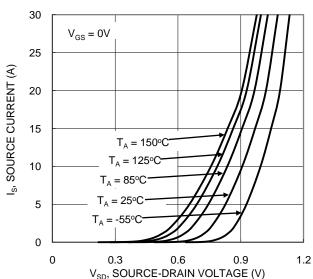
### **Typical Characteristics - P-CHANNEL**





#### **Typical Characteristics - P-CHANNEL (Cont.)**





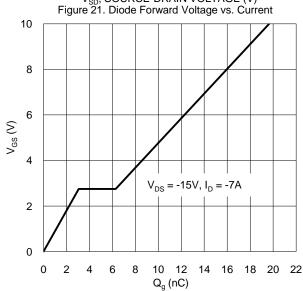


Figure 23. Gate Charge

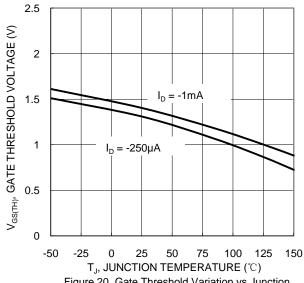
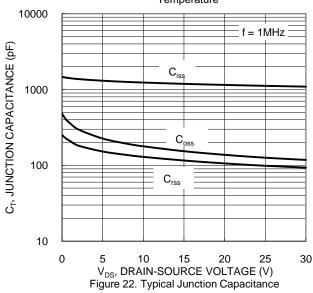


Figure 20. Gate Threshold Variation vs Junction Temperature



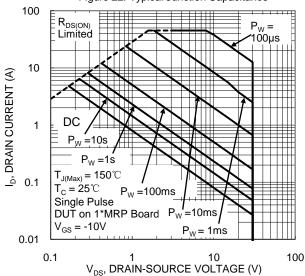


Figure 24. SOA, Safe Operation Area



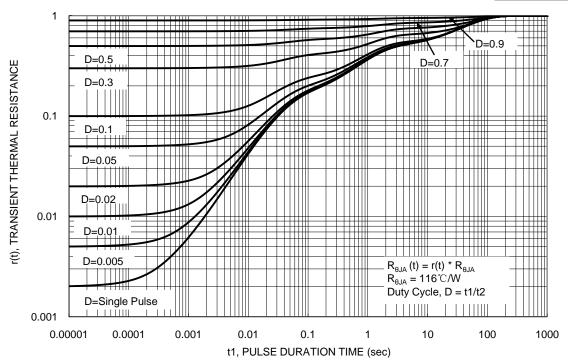


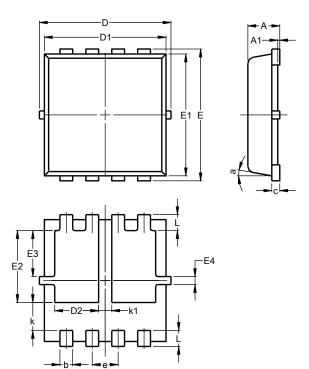
Figure 25. Transient Thermal Resistance



### **Package Outline Dimensions**

Please see http://www.diodes.com/package-outlines.html for the latest version.

#### PowerDI3333-8 (Type UXC)

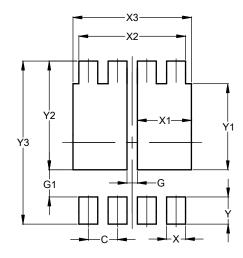


PowerDI3333-8						
(Type UXC)						
Dim	Min	Max	Тур			
Α	0.75	0.85	0.80			
A1	0.00	0.05				
b	0.25	0.40	0.32			
C	0.10	0.25	0.15			
ם	3.20	3.40	3.30			
D1	2.95	3.15	3.05			
D2	0.90	1.30	1.10			
Е	3.20	3.40	3.30			
E1	2.95	3.15	3.05			
E2	1.60	2.00	1.80			
E3	0.95	1.35	1.15			
E4	0.10	0.30	0.20			
е	-	-	0.65			
L	0.30	0.50	0.40			
k	0.50	0.90	0.70			
k1	0.13	0.53	0.33			
а	0°	12°	10°			
All Dimensions in mm						

### **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.

#### PowerDI3333-8 (Type UXC)



Dimensions	Value (in mm)
С	0.650
G	0.230
G1	0.600
Х	0.420
X1	1.200
X2	2.370
Х3	2.630
Y	0.600
Y1	1.900
Y2	2.400
Y3	3.600



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RJK60S3DPP-E0#T2 RJK60S5DPK-M0#T0 APT5010JVFR APT12031JFLL APT12040JVR DMN3404LQ-7 NTE6400 JANTX2N6796U JANTX2N6784U JANTXV2N5416U4 SQM110N05-06L-GE3 SIHF35N60E-GE3 2SK2614(TE16L1,Q)